

Enhanced Product

AD8221-EP

FEATURES

Specified from -55°C to $+125^{\circ}\text{C}$

0.9 $\mu\text{V}/^{\circ}\text{C}$ maximum input offset average TC

10 ppm/ $^{\circ}\text{C}$ maximum gain vs. temperature ($G = 1$)

Excellent ac specifications

80 dB minimum CMRR at 10 kHz ($G = 1$)

-3 dB bandwidth: 825 kHz typical ($G = 1$)

2 V/ μs typical slew rate

Low noise

8 nV/ $\sqrt{\text{Hz}}$, at 1 kHz, maximum input voltage noise

0.25 μV p-p RTI ($G = 100$ to 1000)

High accuracy dc performance

80 dB minimum CMRR DC to 60 Hz ($G = 1$)

70 μV maximum input offset voltage

2 nA maximum input bias current

Wide power supply range: $\pm 2.3 \text{ V}$ to $\pm 18 \text{ V}$

Available in space-saving MSOP

Gain set with 1 external resistor (gain range 1 to 1000)

ENHANCED PRODUCT FEATURES

Supports defense and aerospace applications (AQEC standard)

Military temperature range (-55°C to $+125^{\circ}\text{C}$)

Controlled manufacturing baseline

One assembly/test site

One fabrication site

Enhanced product change notification

Qualification data available on request

APPLICATIONS

Bridge amplifiers

Precision data acquisition systems

Strain gages

Transducer interfaces

TYPICAL CONNECTION DIAGRAM

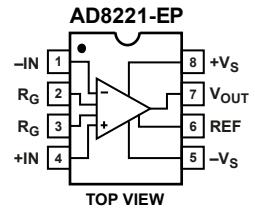


Figure 1.

GENERAL DESCRIPTION

The **AD8221-EP** is a gain programmable, high performance instrumentation amplifier that delivers the industry's highest CMRR over frequency in its class. The CMRR of instrumentation amplifiers on the market today falls off at 200 Hz. In contrast, the **AD8221-EP** maintains a minimum CMRR of 80 dB to 10 kHz at $G = 1$. High CMRR over frequency allows the **AD8221-EP** to reject wideband interference and line harmonics, greatly simplifying filter requirements.

Possible applications include precision data acquisition, biomedical analysis, and aerospace instrumentation.

Low voltage offset, low offset drift, low gain drift, high gain accuracy, and high CMRR make this device an excellent choice in applications that demand the best dc performance possible, such as bridge signal conditioning.

Programmable gain affords the user design flexibility. A single resistor sets the gain from 1 to 1000. The **AD8221-EP** operates on both single and dual supplies and is well suited for applications where $\pm 10 \text{ V}$ input voltages are encountered.

The **AD8221-EP** is specified over the -55°C to $+125^{\circ}\text{C}$ military temperature range. It is available in an 8-lead MSOP package.

Additional application and technical information can be found in the **AD8221** data sheet.

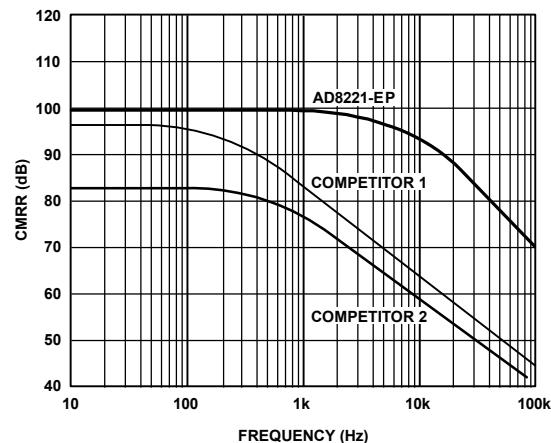


Figure 2. Typical CMRR vs. Frequency for $G = 1$

Rev. 0

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REVISION HISTORY

4/16—Revision 0: Initial Version

SPECIFICATIONS

$V_S = \pm 15$ V, $V_{REF} = 0$ V, $T_A = 25^\circ\text{C}$, $G = 1$, $R_L = 2$ k Ω , unless otherwise noted.

Table 1.

Parameter	Test Conditions/Comments	Min	Typ	Max	Unit
COMMON-MODE REJECTION RATIO (CMRR)					
CMRR DC to 60 Hz with 1 k Ω Source Imbalance					
G = 1	$V_{CM} = -10$ V to +10 V	80			dB
G = 10		100			dB
G = 100		120			dB
G = 1000		130			dB
CMRR at 10 kHz					
G = 1	$V_{CM} = -10$ V to +10 V	80			dB
G = 10		90			dB
G = 100		100			dB
G = 1000		100			dB
NOISE					
Voltage Noise, 1 kHz	$RTI \text{ noise} = \sqrt{e_{NI}^2 + (e_{NO}/G)^2}$				
Input Voltage Noise, e_{NI}	$V_{IN+}, V_{IN-}, V_{REF} = 0$		8		nV/ $\sqrt{\text{Hz}}$
Output Voltage Noise, e_{NO}			75		nV/ $\sqrt{\text{Hz}}$
Referred to Input (RTI)	$f = 0.1$ Hz to 10 Hz				
G = 1		2			$\mu\text{V p-p}$
G = 10		0.5			$\mu\text{V p-p}$
G = 100 to 1000		0.25			$\mu\text{V p-p}$
Current Noise	$f = 1$ kHz	40			fA/ $\sqrt{\text{Hz}}$
	$f = 0.1$ Hz to 10 Hz	6			pA p-p
VOLTAGE OFFSET ¹					
Input Offset, V_{OSI}	$V_S = \pm 5$ V to ± 15 V		70		μV
Over Temperature	$T_A = -55^\circ\text{C}$ to $+125^\circ\text{C}$		150		μV
Average Temperature Coefficient (TC)			0.9		$\mu\text{V}/^\circ\text{C}$
Output Offset, V_{OOS}	$V_S = \pm 5$ V to ± 15 V		600		μV
Over Temperature	$T_A = -55^\circ\text{C}$ to $+125^\circ\text{C}$		1.2		mV
Average TC			9		$\mu\text{V}/^\circ\text{C}$
Offset RTI vs. Supply (PSR)	$V_S = \pm 2.3$ V to ± 18 V				
G = 1		90	100		dB
G = 10		100	120		dB
G = 100		120	140		dB
G = 1000		120	140		dB
INPUT CURRENT					
Input Bias Current		0.5	2		nA
Over Temperature	$T_A = -55^\circ\text{C}$ to $+125^\circ\text{C}$		3.75		nA
Average TC		11			pA/ $^\circ\text{C}$
Input Offset Current		0.3	1		nA
Over Temperature	$T_A = -55^\circ\text{C}$ to $+125^\circ\text{C}$		2.25		nA
Average TC		7			pA/ $^\circ\text{C}$
REFERENCE INPUT					
R_{IN}		20			k Ω
I_{IN}	$V_{IN+}, V_{IN-}, V_{REF} = 0$	50	60		μA
Voltage Range	$-V_S$			+ V_S	V
Gain to Output		1 \pm 0.0001			V/V

Parameter	Test Conditions/Comments	Min	Typ	Max	Unit
POWER SUPPLY					
Operating Range	$V_S = \pm 2.3 \text{ V to } \pm 18 \text{ V}$	± 2.3		± 18	V
Quiescent Current		0.9	1		mA
Over Temperature	$T_A = -55^\circ\text{C to } +125^\circ\text{C}$	1	1.2		mA
DYNAMIC RESPONSE					
Small Signal –3 dB Bandwidth					
G = 1		825			kHz
G = 10		562			kHz
G = 100		100			kHz
G = 1000		14.7			kHz
Settling Time 0.01%	10 V step				
G = 1 to 100		10			μs
G = 1000		80			μs
Settling Time 0.001%	10 V step				
G = 1 to 100		13			μs
G = 1000		110			μs
Slew Rate	G = 1	1.5	2		V/μs
	G = 5 to 100	2	2.5		V/μs
GAIN	$G = 1 + (49.4 \text{ k}\Omega/R_G)$				
Gain Range		1		1000	V/V
Gain Error	$V_{OUT} \pm 10 \text{ V}$				
G = 1			0.1		%
G = 10			0.3		%
G = 100			0.3		%
G = 1000			0.3		%
Gain Nonlinearity	$V_{OUT} = -10 \text{ V to } +10 \text{ V}$				
G = 1 to 10	$R_L = 10 \text{ k}\Omega$	5	15		ppm
G = 100	$R_L = 10 \text{ k}\Omega$	7	20		ppm
G = 1000	$R_L = 10 \text{ k}\Omega$	10	50		ppm
G = 1 to 100	$R_L = 2 \text{ k}\Omega$	15	100		ppm
Gain vs. Temperature					
G = 1		3	10		ppm/°C
G > 1 ²			-50		ppm/°C
INPUT					
Input Impedance					
Differential		100 2			$\text{G}\Omega \text{pF}$
Common Mode		100 2			$\text{G}\Omega \text{pF}$
Input Operating Voltage Range ³	$V_S = \pm 2.3 \text{ V to } \pm 5 \text{ V}$	$-V_S + 1.9$		$+V_S - 1.1$	V
Over Temperature	$T_A = -55^\circ\text{C to } +125^\circ\text{C}$	$-V_S + 2.0$		$+V_S - 1.2$	V
Input Operating Voltage Range	$V_S = \pm 5 \text{ V to } \pm 18 \text{ V}$	$-V_S + 1.9$		$+V_S - 1.2$	V
Over Temperature	$T_A = -55^\circ\text{C to } +125^\circ\text{C}$	$-V_S + 2.0$		$+V_S - 1.3$	V
OUTPUT	$R_L = 10 \text{ k}\Omega$				
Output Swing	$V_S = \pm 2.3 \text{ V to } \pm 5 \text{ V}$	$-V_S + 1.1$		$+V_S - 1.2$	V
Over Temperature	$T_A = -55^\circ\text{C to } +125^\circ\text{C}$	$-V_S + 1.4$		$+V_S - 1.3$	V
Output Swing	$V_S = \pm 5 \text{ V to } \pm 18 \text{ V}$	$-V_S + 1.2$		$+V_S - 1.4$	V
Over Temperature	$T_A = -55^\circ\text{C to } +125^\circ\text{C}$	$-V_S + 1.6$		$+V_S - 1.5$	V
Short-Circuit Current		18			mA
TEMPERATURE RANGE					
Specified Performance		-55		+125	°C

¹ Total RTI $V_{OS} = (V_{OS1}) + (V_{OS0}/G)$.² Does not include the effects of external resistor R_G .³ One input grounded. G = 1.

ABSOLUTE MAXIMUM RATINGS

Table 2.

Parameter	Rating
Supply Voltage	$\pm 18\text{ V}$
Internal Power Dissipation	200 mW
Output Short-Circuit Current	Indefinite
Input Voltage (Common-Mode)	$\pm V_s$
Differential Input Voltage	$\pm V_s$
Storage Temperature Range	-65°C to +150°C
Operating Temperature Range	-55°C to +125°C

Stresses at or above those listed under Absolute Maximum Ratings may cause permanent damage to the product. This is a stress rating only; functional operation of the product at these or any other conditions above those indicated in the operational section of this specification is not implied. Operation beyond the maximum operating conditions for extended periods may affect product reliability.

THERMAL CHARACTERISTICS

Specification for a device in free air.

Table 3.

Package	θ_{JA}	Unit
8-Lead MSOP, 4-Layer JEDEC Board	135	°C/W

ESD CAUTION

**ESD (electrostatic discharge) sensitive device.**

Charged devices and circuit boards can discharge without detection. Although this product features patented or proprietary protection circuitry, damage may occur on devices subjected to high energy ESD. Therefore, proper ESD precautions should be taken to avoid performance degradation or loss of functionality.

PIN CONFIGURATION AND FUNCTION DESCRIPTIONS

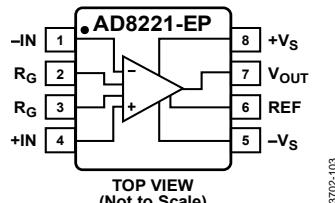


Figure 3. Pin Configuration

Table 4. Pin Function Descriptions

Pin No.	Mnemonic	Description
1	-IN	Negative Input Terminal.
2, 3	R _G	Gain Setting Terminal. Place resistor across the R _G pins to set the gain. G = 1 + (49.4 kΩ/R _G).
4	+IN	Positive Input Terminal.
5	-V _S	Negative Power Supply Terminal.
6	REF	Reference Voltage Terminal. Drive this terminal with a low impedance voltage source to level-shift the output.
7	V _{OUT}	Output Terminal.
8	+V _S	Positive Power Supply Terminal.

TYPICAL PERFORMANCE CHARACTERISTICS

$T = 25^\circ\text{C}$, $V_S = \pm 15\text{ V}$, $R_L = 10\text{ k}\Omega$, unless otherwise noted.

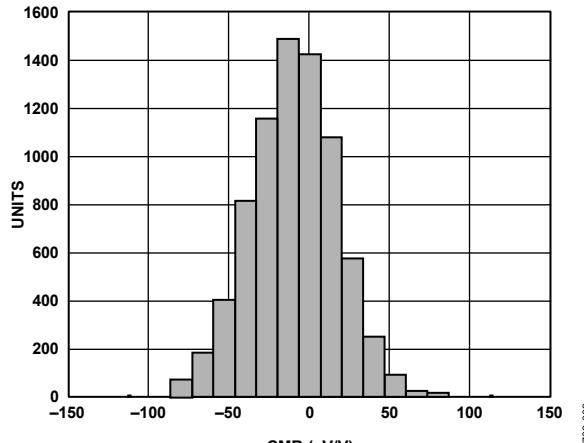


Figure 4. Typical Distribution for CMR ($G = 1$)

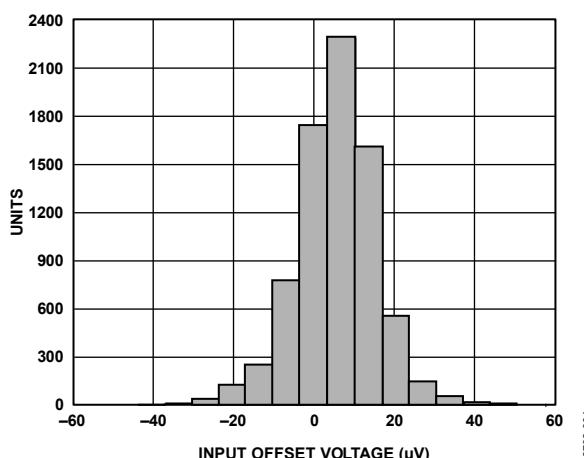


Figure 5. Typical Distribution of Input Offset Voltage

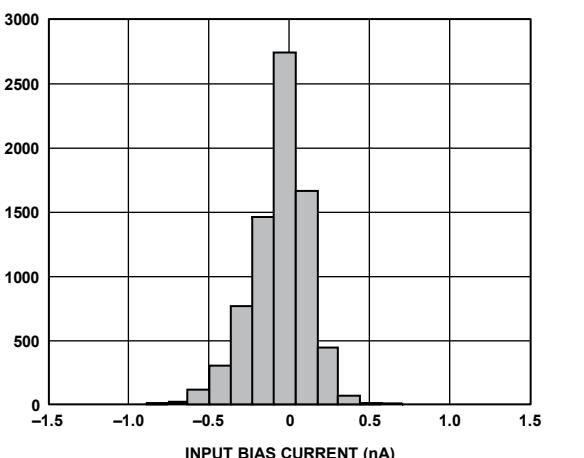


Figure 6. Typical Distribution of Input Bias Current

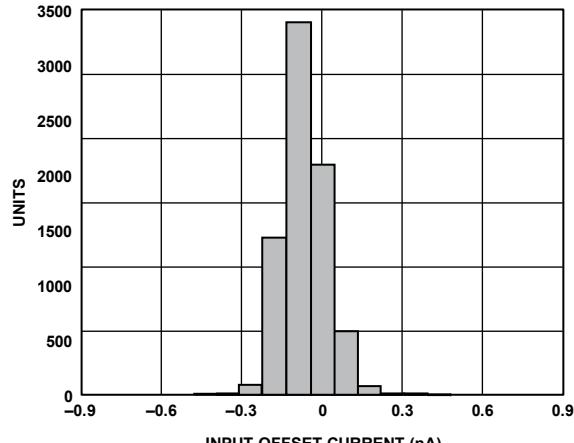


Figure 7. Typical Distribution of Input Offset Current

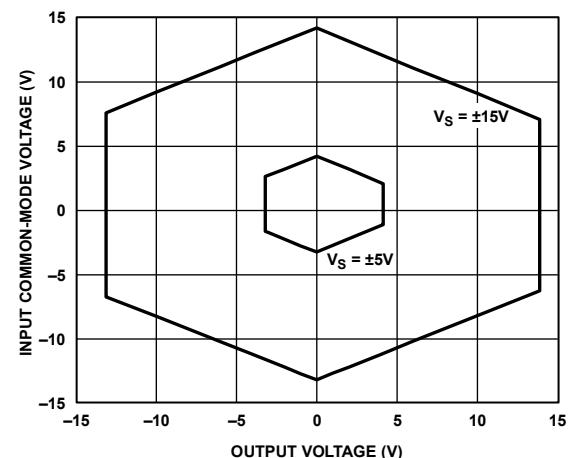


Figure 8. Input Common-Mode Voltage vs. Output Voltage, $G = 1$

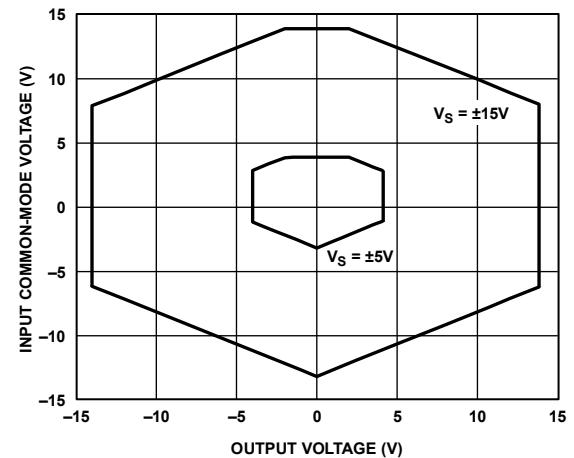


Figure 9. Input Common-Mode Voltage vs. Output Voltage, $G = 100$

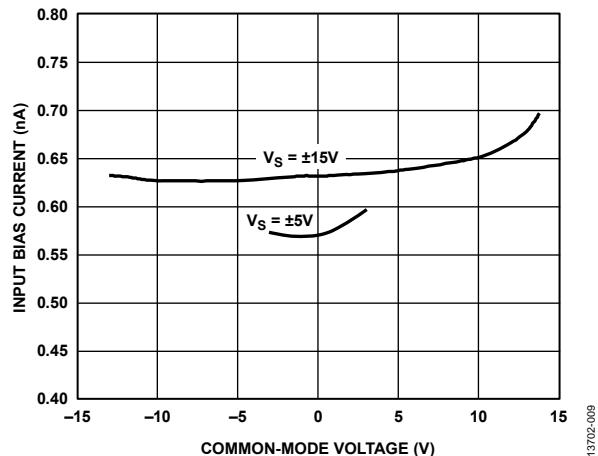
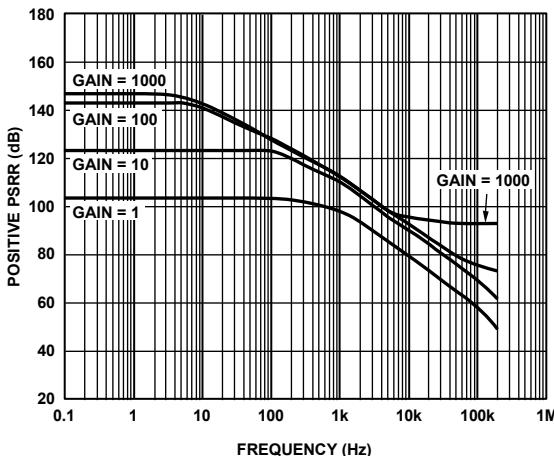
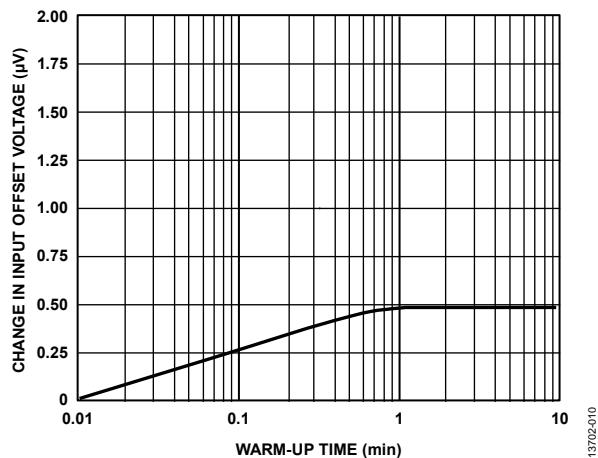
Figure 10. Input Bias Current (I_{BIAS}) vs. Common-Mode Voltage (CMV)Figure 13. Positive PSRR vs. Frequency, RTI ($G = 1$ to 1000)

Figure 11. Change in Input Offset Voltage vs. Warm-Up Time

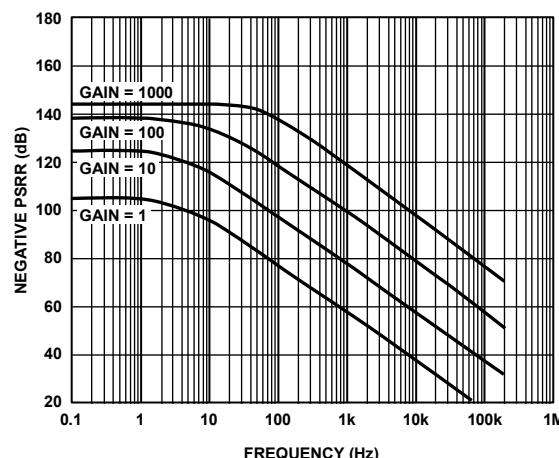
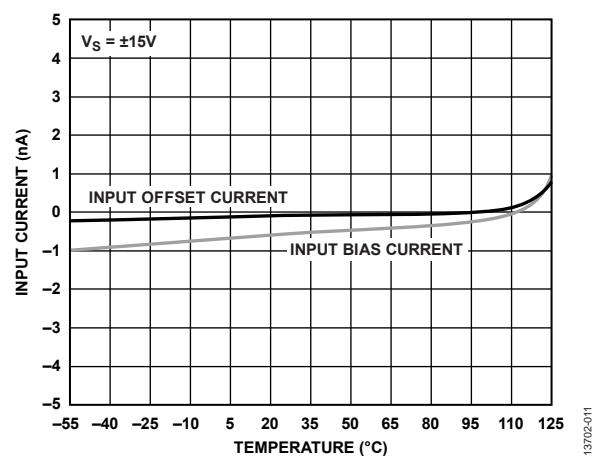
Figure 14. Negative PSRR vs. Frequency, RTI ($G = 1$ to 1000)

Figure 12. Input Offset Current and Input Bias Current vs. Temperature

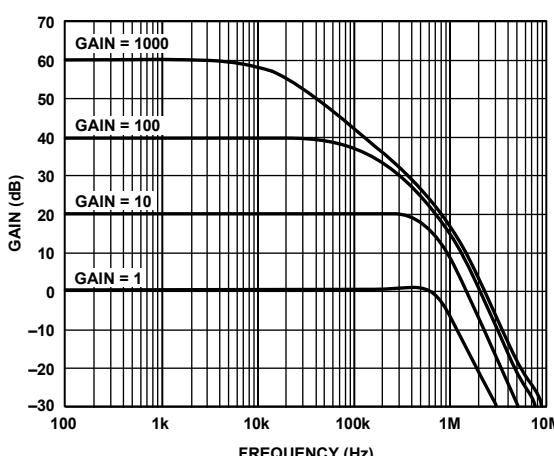


Figure 15. Gain vs. Frequency

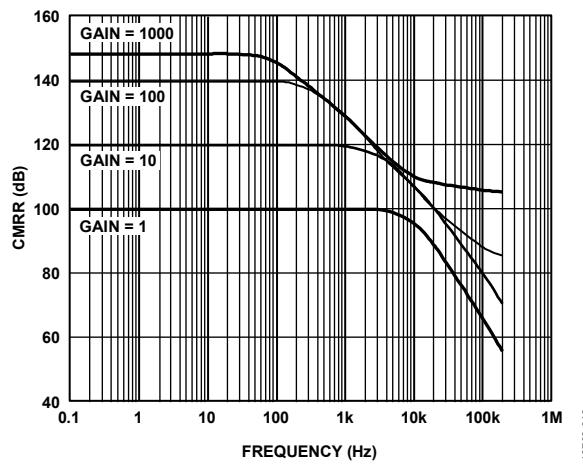


Figure 16. CMRR vs. Frequency, RTI

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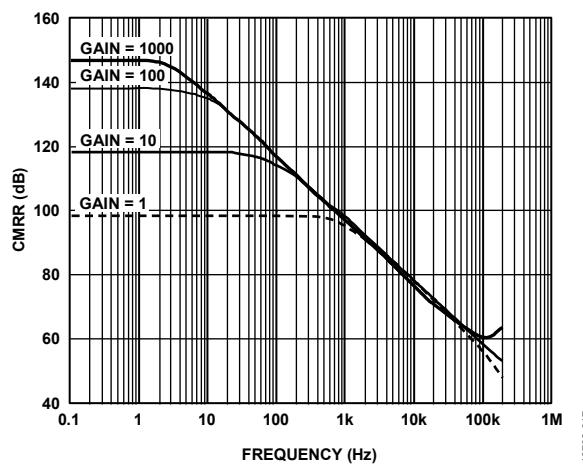


Figure 17. CMRR vs. Frequency, RTI, 1 kΩ Source Imbalance

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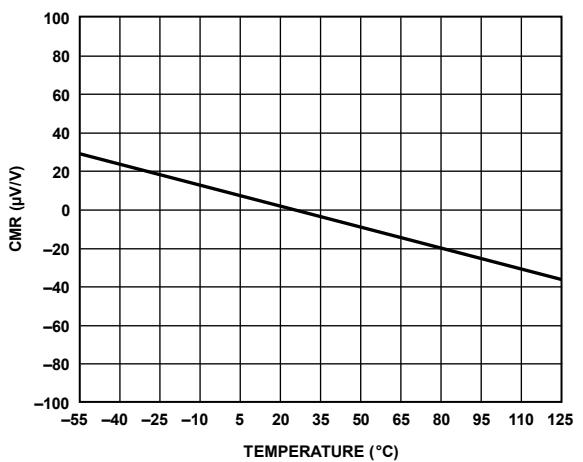


Figure 18. CMR vs. Temperature

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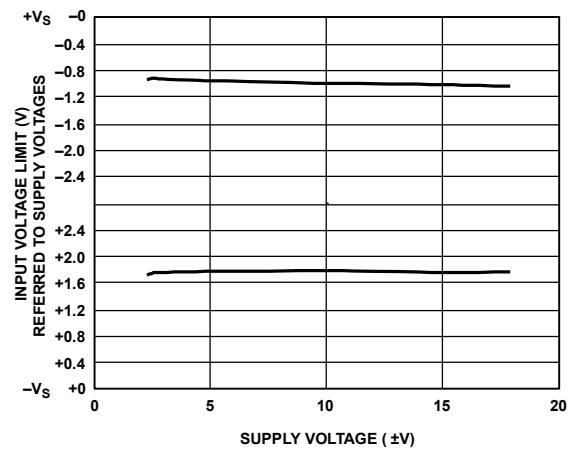


Figure 19. Input Voltage Limit vs. Supply Voltage, G = 1

13702-019

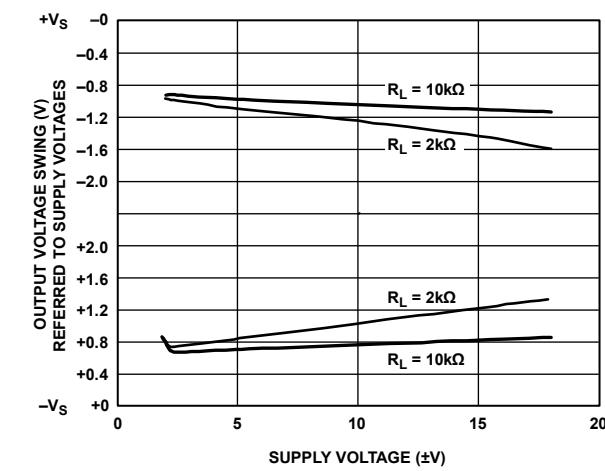


Figure 20. Output Voltage Swing vs. Supply Voltage, G = 1

13702-020

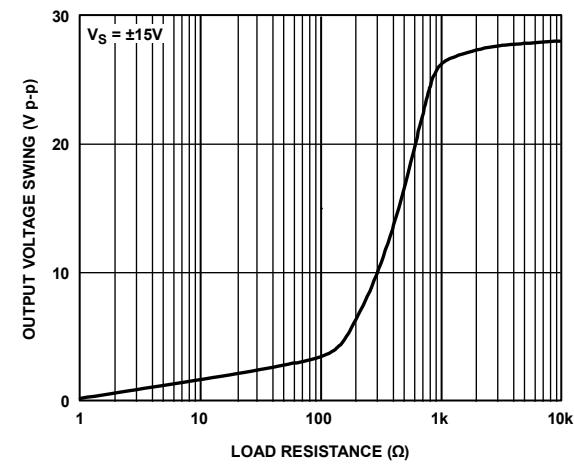
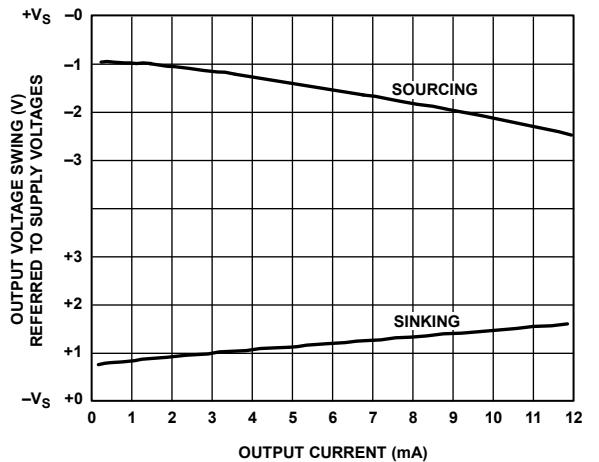
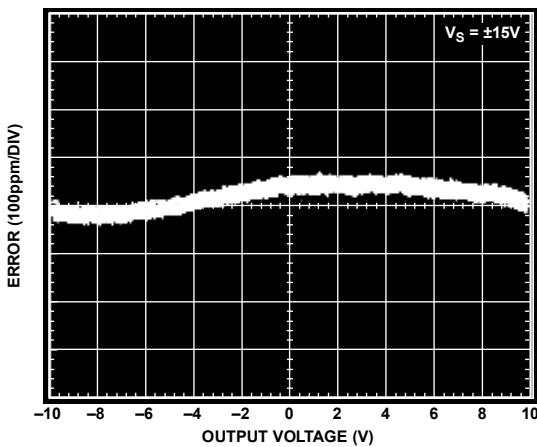


Figure 21. Output Voltage Swing vs. Load Resistance

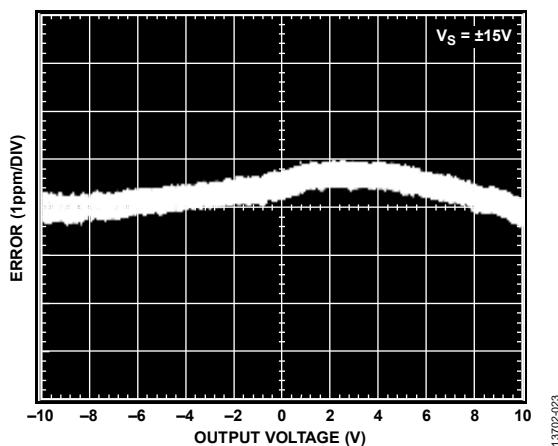
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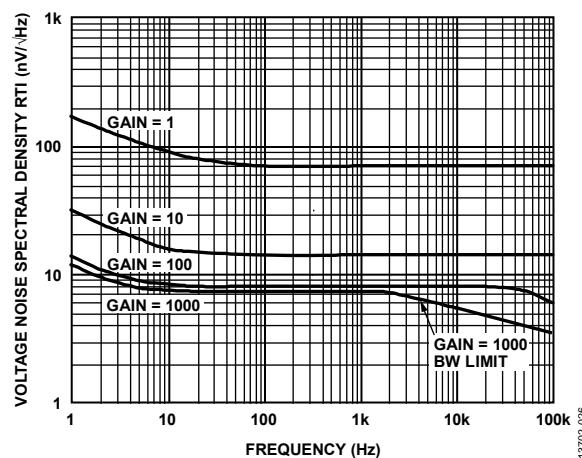
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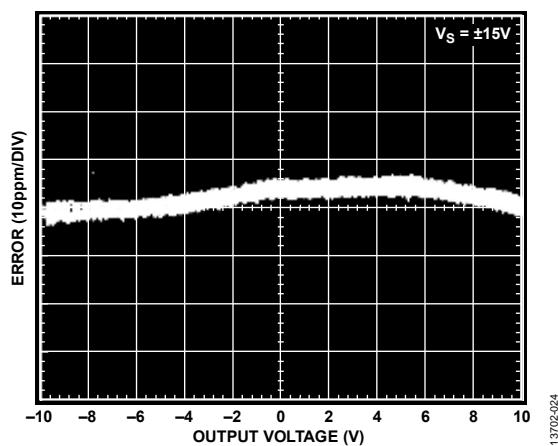
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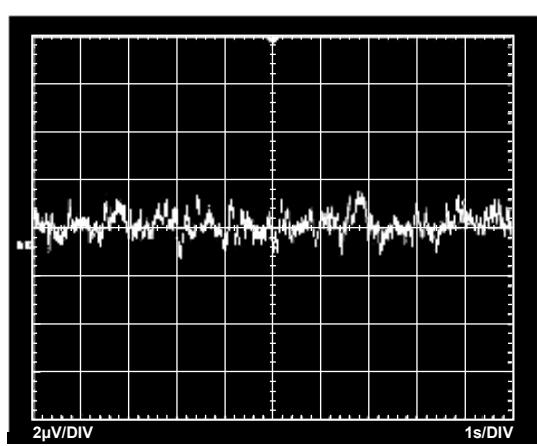
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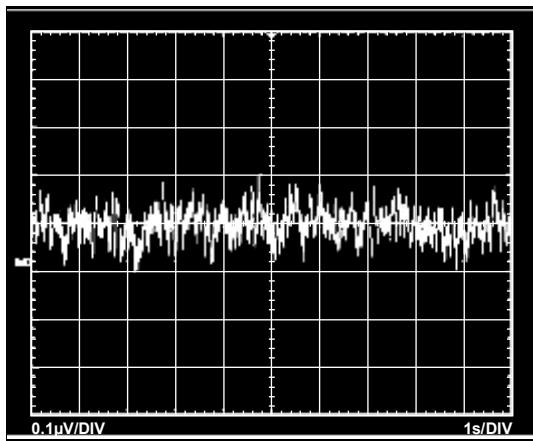
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13702-027



13702-028

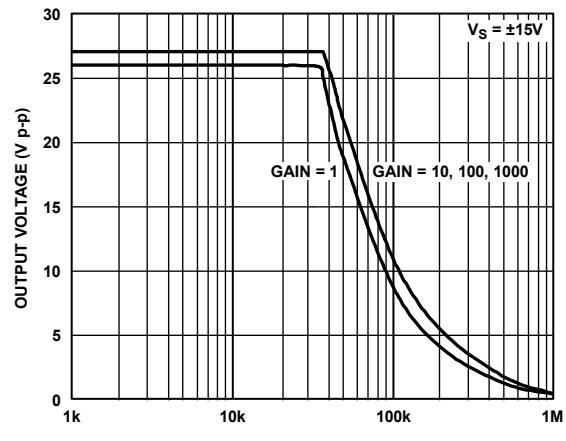
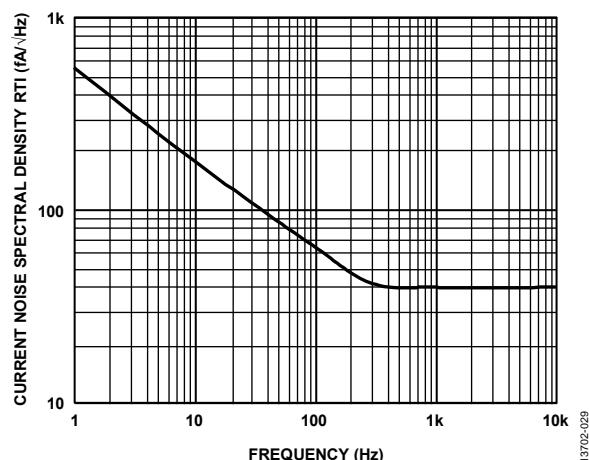


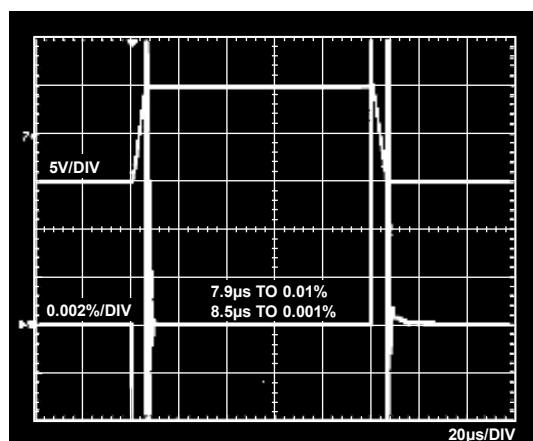
Figure 31. Large Signal Frequency Response

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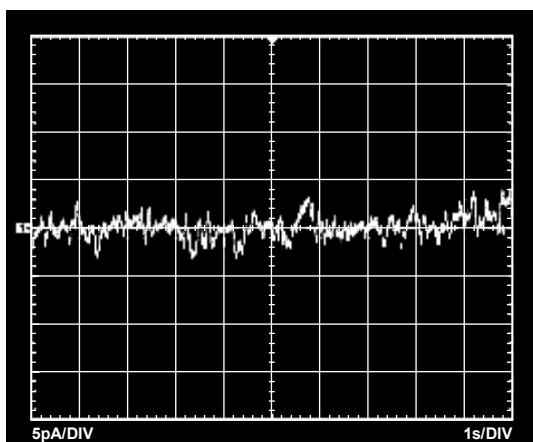


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Figure 29. Current Noise Spectral Density vs. Frequency

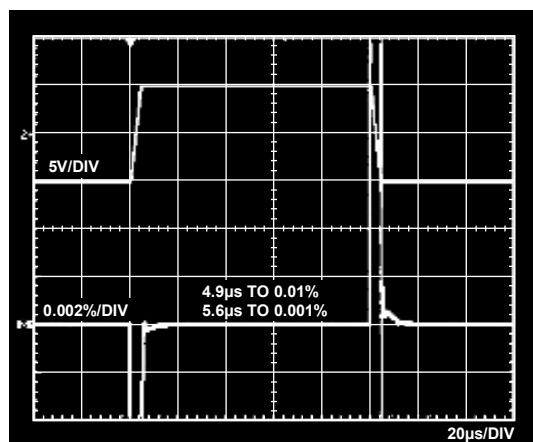


13702-032

Figure 32. Large Signal Pulse Response and Settling Time ($G = 1$), 0.002%/DIV

13702-030

Figure 30. 0.1 Hz to 10 Hz Current Noise



13702-033

Figure 33. Large Signal Pulse Response and Settling Time ($G = 10$), 0.002%/DIV

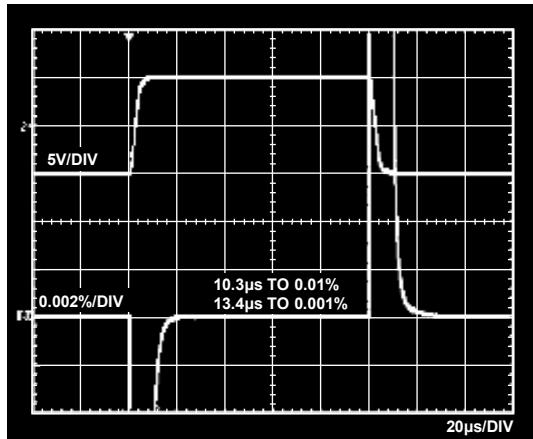


Figure 34. Large Signal Pulse Response and Settling Time ($G = 100$),
0.002%/DIV

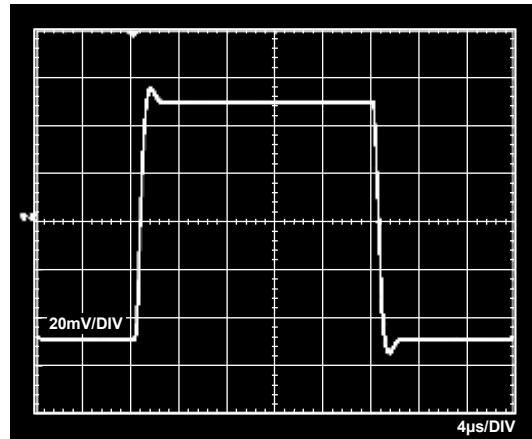


Figure 37. Small Signal Response, $G = 10$, $R_L = 2 \text{ k}\Omega$, $C_L = 100 \text{ pF}$

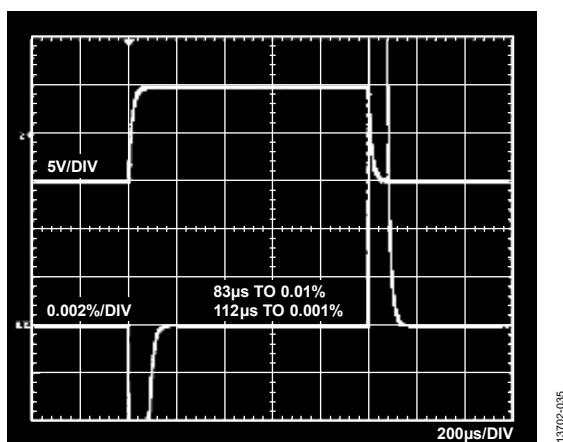


Figure 35. Large Signal Pulse Response and Settling Time ($G = 1000$),
0.002%/DIV

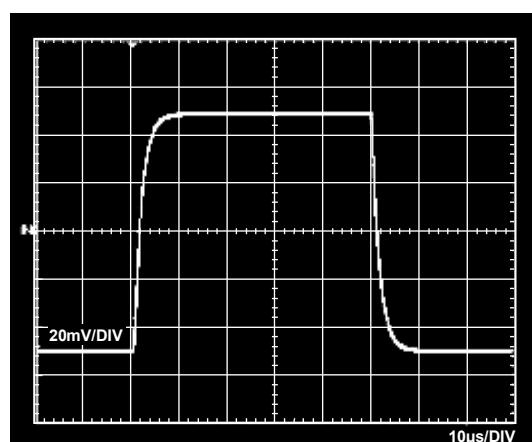


Figure 38. Small Signal Response, $G = 100$, $R_L = 2 \text{ k}\Omega$, $C_L = 100 \text{ pF}$

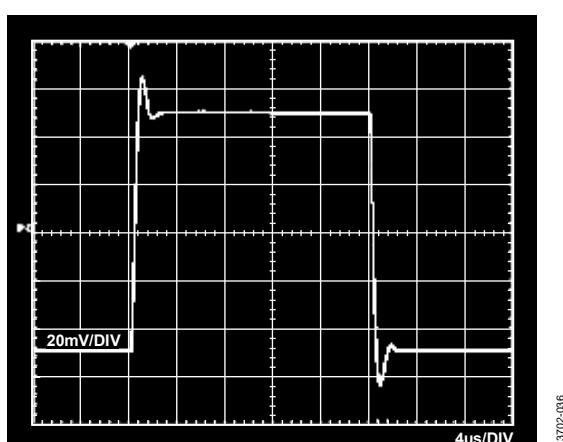


Figure 36. Small Signal Response, $G = 1$, $R_L = 2 \text{ k}\Omega$, $C_L = 100 \text{ pF}$

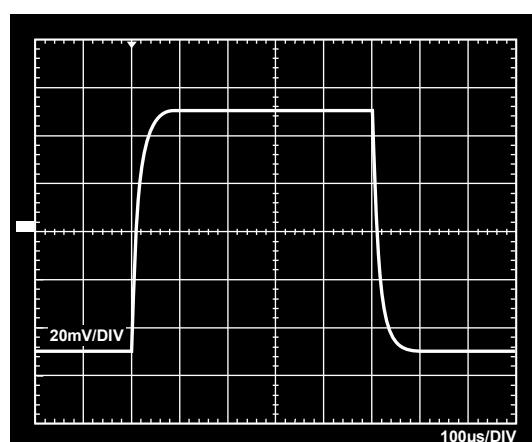
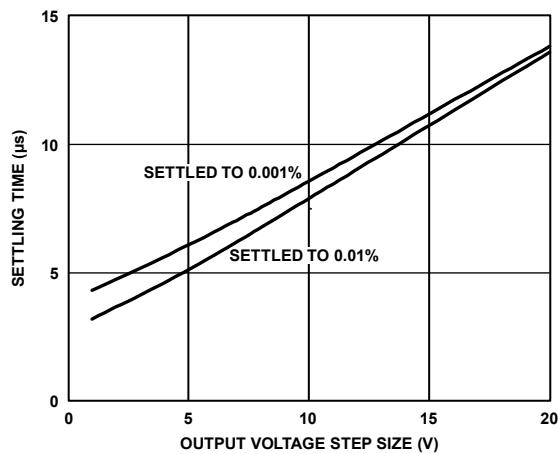


Figure 39. Small Signal Response, $G = 1000$, $R_L = 2 \text{ k}\Omega$, $C_L = 100 \text{ pF}$

Figure 40. Settling Time vs. Output Voltage Step Size ($G = 1$)

13702-040

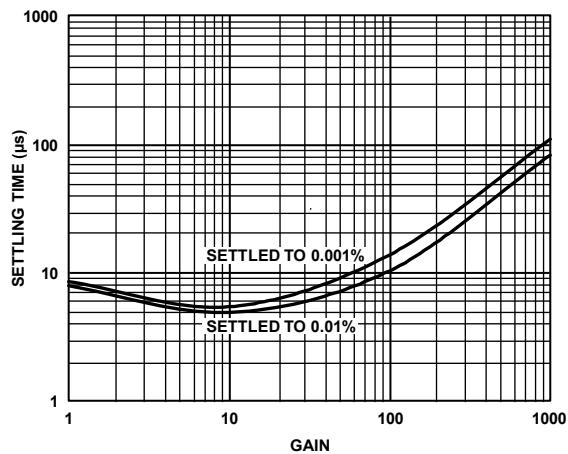


Figure 41. Settling Time vs. Gain for a 10 V Step

13702-041

OUTLINE DIMENSIONS

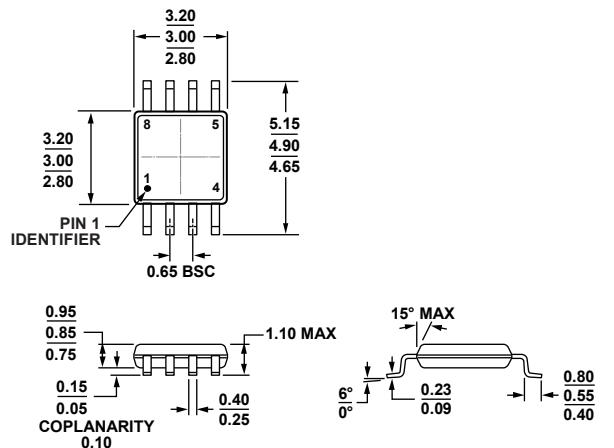


Figure 42. 8-Lead Mini Small Outline Package [MSOP]
(RM-8)
Dimensions shown in millimeters

10-07-2009-B

ORDERING GUIDE

Model ¹	Temperature Range	Package Description	Package Option	Branding
AD8221TRMZ-EP	-55°C to +125°C	8-Lead Mini Small Outline Package [MSOP]	RM-8	Y67
AD8221TRMZ-EP-R7	-55°C to +125°C	8-Lead Mini Small Outline Package [MSOP]	RM-8	Y67

¹ Z = RoHS Compliant Part.

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